1200 V SiC MPS<sup>™</sup> Diode

## Silicon Carbide Power Schottky Diode

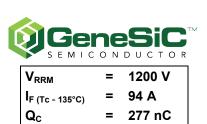
## Features

- High Avalanche (UIS) Capability
- Enhanced Surge Current Capability
- 175 °C Maximum Operating Temperature
- Temperature Independent Switching Behavior
- Positive Temperature Coefficient Of  $V_{\text{F}}$
- Extremely Fast Switching Speeds
- Superior Figure of Merit  $Q_C/I_F$

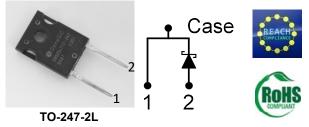
#### **Advantages**

- Low Standby Power Losses
- Improved Circuit Efficiency (Lower Overall Cost)
- Low Switching Losses
- Ease of Paralleling Devices without Thermal Runaway
- Smaller Heat Sink Requirements
- Low Reverse Recovery Current
- Low Device Capacitance
- Low Reverse Leakage Current at Operating Temperature

#### **Absolute Maximum Ratings**



#### Package



## Applications

- Power Factor Correction (PFC)
- Switched-Mode Power Supply (SMPS)
- Solar Inverters
- Wind Turbine Inverters
- Motor Drives
- Induction Heating
- Uninterruptible Power Supply (UPS)
- High Voltage Multipliers

Parameter	Symbol	Conditions	Values	Unit	
Repetitive Peak Reverse Voltage	V <sub>RRM</sub>		1200	V	
		T <sub>C</sub> = 25 °C, D = 1	191		
Continuous Forward Current	I <sub>F</sub>	T <sub>C</sub> = 135 °C, D = 1	94	А	
		T <sub>C</sub> = 162 °C, D = 1	50		
Non-Repetitive Peak Forward Surge Current,	1	T <sub>C</sub> = 25 °C, t <sub>P</sub> = 10 ms	320	А	
Half Sine Wave	I <sub>F,SM</sub>	$T_{\rm C}$ = 150 °C, $t_{\rm P}$ = 10 ms	280		
Repetitive Peak Forward Surge Current, Half		T <sub>C</sub> = 25 °C, t <sub>P</sub> = 10 ms	220	٨	
Sine Wave	I <sub>F,RM</sub>	T <sub>C</sub> = 150 °C, t <sub>P</sub> = 10 ms	150	A	
Non-Repetitive Peak Forward Surge Current	I <sub>F,max</sub>	T <sub>C</sub> = 25 °C, t <sub>P</sub> = 10 μs	1400	А	
<sup>2</sup> t Value	∫i² dt	T <sub>C</sub> = 25 °C, t <sub>P</sub> = 10 ms	300	A <sup>2</sup> s	
Non-Repetitive Avalanche Energy	E <sub>AS</sub>	L = 1 mH, I <sub>AV</sub> = 42 A, V <sub>DD</sub> = 60 V	450	mJ	
Diode Ruggedness	dV/dt	V <sub>R</sub> = 0 ~ 960 V	100	V/µs	
Power Dissipation	P <sub>tot</sub>	T <sub>C</sub> = 25 °C	1241	Ŵ	
Operating and Storage Temperature	T <sub>i</sub> , T <sub>stq</sub>		-55 to 175	°C	

#### **Electrical Characteristics**

Parameter	Symphol	Conditions -		Values		11	
	Symbol			min.	typ.	max.	Unit
Diode Forward Voltage	V <sub>F</sub>	I <sub>F</sub> = 50 A, T <sub>j</sub> = 1 I <sub>F</sub> = 50 A, T <sub>i</sub> = 1			1.5 2.3	1.8 2.7	V
Reverse Current	I <sub>R</sub>	V <sub>R</sub> = 1200 V, T <sub>j</sub> = V <sub>R</sub> = 1200 V, T <sub>j</sub> =	= 25 °C		5 40	70 475	μA
Total Capacitive Charge	Qc	$ _{F} \leq  _{F,MAX}$	V <sub>R</sub> = 400 V V <sub>R</sub> = 800 V		186 277		nC
Switching Time	ts	− dI <sub>F</sub> /dt = 200 A/µs T <sub>j</sub> = 175 °C	V <sub>R</sub> = 400 V V <sub>R</sub> = 800 V		< 10		ns
Total Capacitance	С	V <sub>R</sub> = 1 V, f = 1 MHz, T <sub>j</sub> = 25 °C V <sub>R</sub> = 800 V, f = 1 MHz, T <sub>j</sub> = 25 °C		3037 203		pF	

## **Thermal / Mechanical Characteristics**

	Thermal Resistance, Junction - Case	R <sub>thJC</sub>	0.12	°C/W
--	-------------------------------------	-------------------	------	------



1200 V SiC MPS<sup>™</sup> Diode

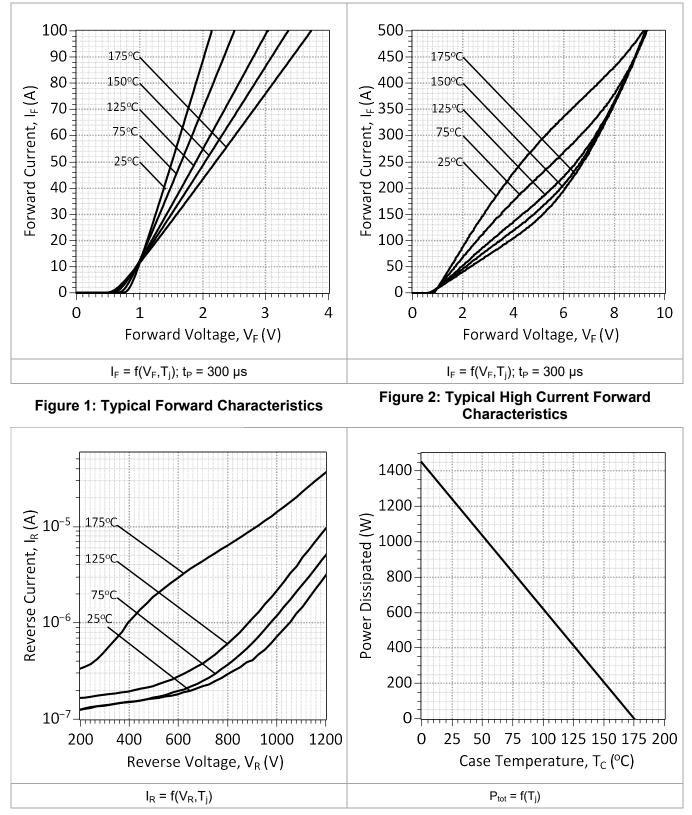
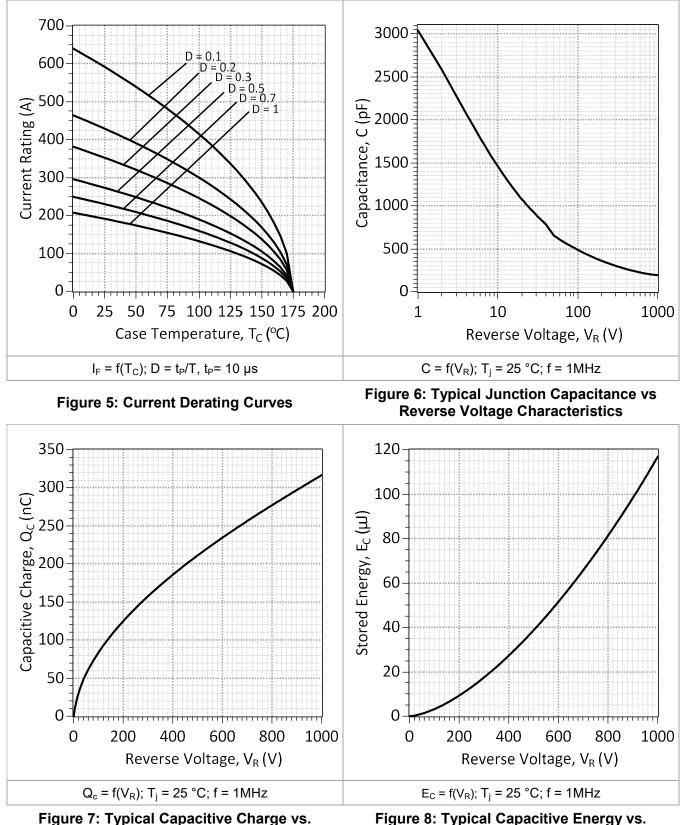




Figure 4: Power Derating Curve



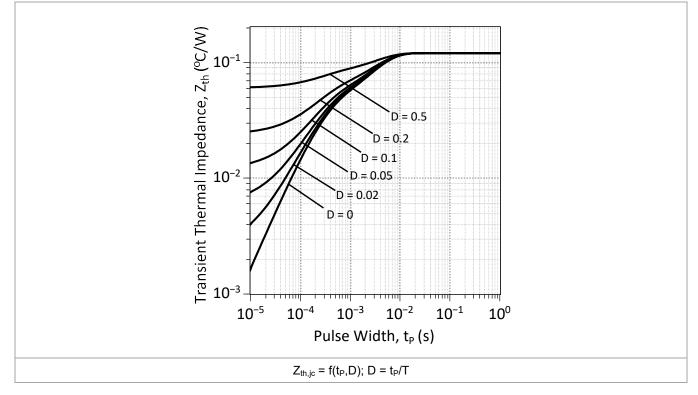


Reverse Voltage Characteristics

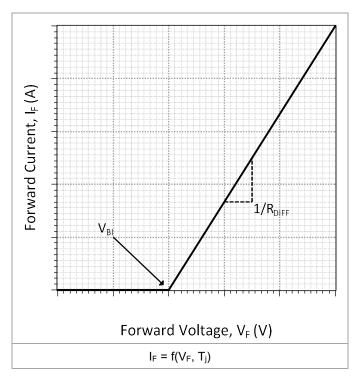
Figure 8: Typical Capacitive Energy vs. Reverse Voltage Characteristics







**Figure 9: Transient Thermal Impedance** 





 $I_F = (V_F - V_{BI})/R_{DIFF}$ 

Built-In Voltage (V<sub>BI</sub>):

 $V_{Bl}(T_j) = m^*T_j + b,$ m = -1.29e-03, b = 0.913

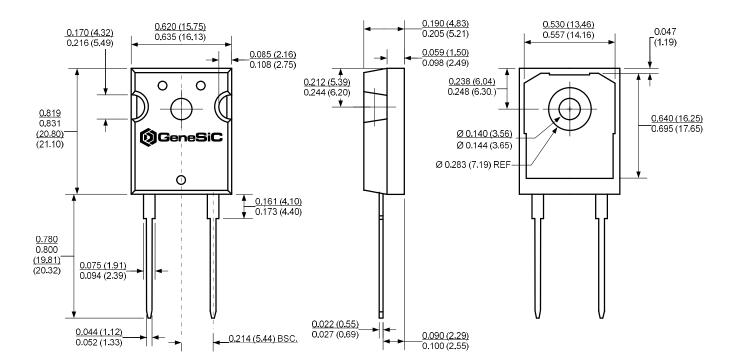
**Differential Resistance (R<sub>DIFF</sub>):**  $R_{DIFF}(T_j) = a^{*}T_j^2 + b^{*}T_j + c (\Omega);$ a = 6.10e-05, b = 9.01e-03, c = 2.01

## 1200 V SiC MPS™ Diode

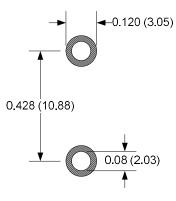
#### **Package Dimensions:**

## TO-247-2L

## PACKAGE OUTLINE



#### **Recommended Solder Pad Layout**



#### NOTE

- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS





## 1200 V SiC MPS™ Diode

#### **RoHS Compliance**



The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your GeneSiC representative.

## **REACH Compliance**

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, or air traffic control systems.

GeneSiC disclaims all and any warranty and liability arising out of use or application of any product. No license, express or implied to any intellectual property rights is granted by this document.

#### **Related Links**

- Soldering Document: http://www.genesicsemi.com/quality/quality-manual/
- Tin-whisker Report: http://www.genesicsemi.com/quality/compliance/
- Reliability Report: http://www.genesicsemi.com/quality/reliability/



Copyright © 2018 GeneSiC Semiconductor Inc. All Rights Reserved The information in this document is subject to change without notice Published by GeneSiC Semiconductor, Inc. 43670 Trade Center Place Suite 155 Dulles, VA 20166 Page 6 of 6

1200 V SiC MPS<sup>™</sup> Diode



## **SPICE Model Parameters**

This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/sic\_rectifiers\_diodes/merged\_pin\_schottky/GB50SLT12-247\_SPICE.pdf) into LTSPICE (version 4) software for simulation of the GB50SLT12-247.

```
GeneSiC Semiconductor SiC MPS<sup>™</sup> Rectifier
*
*
    Revision: 1.1
    Date: February-2018
**
        TO-247-2 package
.SUBCKT GB50SLT12 A K Case
L anode
       А
             AD
                   6.5n
                   GC50MPS12
D1
        AD
             Case
                   6.5n
L cathode K
             Case
.ends
.SUBCKT GB50SLT12 ANODE KATHODE
D1 ANODE KATHODE GC50MPS12 SCHOTTKY
.MODEL GC50MPS12 SCHOTTKY D
        4.27E-14
+ IS
                            0.0124
                    RS
+ N
        1
                    IKF
                            500
+ EG
        1.2
                    XTI
                            2
+ TRS1
        0.005434
                            2.717E-05
                    TRS2
+ CJO
        4.24E-9
                    VJ
                            0.879
        0.438
+ M
                    FC
                            0.5
+ TT
       1.00E-10
                    ΒV
                            1600
+ IBV
        5E-06
                    VPK
                            1200
                            SiC MPS<sup>™</sup>
+ TAVE
        50
                    TYPE
+ MFG
        GeneSiC Semi
.ENDS
* End of GB50SLT12-247 SPICE Model
* This model is provided "AS IS, WHERE IS, AND WITH NO WARRANTY OF ANY KIND
* EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED TO ANY IMPLIED
```

\* WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE."